











TLC082-Q1, TLC084-Q1

SLOS510E - SEPTEMBER 2006-REVISED OCTOBER 2016

TLC08x-Q1 Wide-Bandwidth High-Output-Drive Single-Supply Operational Amplifiers

Features

Wide Bandwidth: 10 MHz

High-Output Drive

I_{OH}: 57 mA at V_{DD} –1.5 V

I_{OL}: 55 mA at 0.5 V

High Slew Rate

SR+: 16 V/μs

SR-: 19 V/μs

Wide Supply Range: 4.5 V to 16 V

Supply Current: 1.9 mA per Channel

Low Input Noise Voltage: 8.5 nV√Hz

Input Offset Voltage: 60 μV

Ultra-Small 8-Pin MSOP-PowerPAD Package for

TLC082-Q1

Applications

- Automotive
- Blind Spot Detection
- **Engine Control Units**
- **Electric Mirrors**
- **HVAC**
- Steering
- **Collision Warnings**
- **Telematics**
- Clusters
- Audio
- Industrial
- Instrumentations

3 Description

The TLC08x-Q1 is the first general purpose operational amplifier to highlight TI's BiCMOS technology. The BiMOS family concept is simple: provide an upgrade path for BiFET users who are moving away from dual-supply to single-supply systems and demand higher AC and performance. With performance rated from 4.5 V to 16 V across an automotive temperature range (-40°C to 125°C), BiMOS suits a wide range of audio, and automotive, industrial, instrumentation applications.

Developed in Tl's patented LBC3 BiCMOS process, the BiMOS amplifiers combine a very high input impedance, low-noise CMOS front end with a highdrive bipolar output stage, thus providing the optimum performance features of both. AC performance improvements over the TL08x-Q1 predecessors include a bandwidth of 10 MHz and voltage noise of 8.5 nV/\(\sqrt{Hz}\). These features enable the TLC08x-Q1 devices to be suitable for ADAS (such as short-range radar) and body in automotive. The TLC082-Q1 is also suitable in infotainment and cluster as a pre amp in car audio applications.

DC improvements include an ensured V_{ICR} that includes ground, a factor of four reduction in input offset voltage down to 1.5 mV (maximum), and a power-supply rejection improvement of greater than 40 dB to 130 dB. Added to this list of impressive features is the ability to drive ±50-mA loads comfortably from an ultrasmall-footprint MSOP PowerPAD™ package, which positions the TLC08x-Q1 as the ideal high-performance, general-purpose operational amplifier family.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TLC082-Q1	MSOP-PowerPAD (8)	3.00 mm × 3.00 mm
TLC084-Q1	HTSSOP (20)	6.50 mm × 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Operational Amplifier

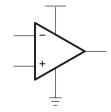




Table of Contents

1	Features 1		8.4 Device Functional Modes	16
2	Applications 1		8.5 Programming	
3	Description 1	9	Application and Implementation	18
4	Revision History2		9.1 Application Information	18
5	Pin Configuration and Functions 3		9.2 Typical Applications	18
6	Specifications4	10	Power Supply Recommendations	23
•	6.1 Absolute Maximum Ratings 4	11	Layout	23
	6.2 ESD Ratings		11.1 Layout Guidelines	23
	6.3 Recommended Operating Conditions		11.2 Layout Example	26
	6.4 Thermal Information	12	Device and Documentation Support	<mark>27</mark>
	6.5 Electrical Characteristics: V _{DD} = 5 V		12.1 Documentation Support	27
	6.6 Electrical Characteristics: V _{DD} = 12 V		12.2 Related Links	27
	6.7 Operating Characteristics: V _{DD} = 5 V		12.3 Receiving Notification of Documentsation	27
	6.8 Operating Characteristics: V _{DD} = 12 V		Updates	
	6.9 Typical Characteristics 8		12.4 Community Resources	
7	Parameter Measurement Information 15		12.5 Trademarks	
8	Detailed Description 16		12.6 Electrostatic Discharge Caution	
	8.1 Overview 16		12.7 Glossary	27
	8.2 Functional Block Diagram	13	Mechanical, Packaging, and Orderable Information	27
	8.3 Feature Description			27

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

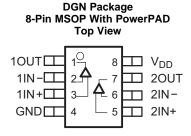
C	Changes from Revision D (August 2016) to Revision E	Page
•	Changed y-axis label from Phase Margin to Gain Margin for the Gain Margin vs Load Capacitance graph	11
C	Changes from Revision C (January 2016) to Revision D	Page
•	Deleted the Maximum Power Dissipation vs Free-Air Temperature graph	25
•	Added the Receiving Notification of Documentation Updates section	27
C	Changes from Revision B (May 2011) to Revision C	Page
•	Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device Function Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device	nal e
	and Documentation Support section, and Mechanical, Packaging, and Orderable Information section	
•	200000 Chalon I ono Chalo mode said non I oddio	
•	Deleted Typical Pin Indicators image from Pin Configuration and Functions	3
	Deleted VIH and VIL rows in Recommended Operating Conditions	

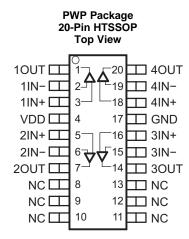
Deleted Shutdown Forward and Reverse Isolation vs Frequency graphs (formerly Figures 38 and 39) from Typical

Submit Documentation Feedback



5 Pin Configuration and Functions





NC - No internal connection

Pin Functions

				i iii i dilodolis	
	PIN				
NAME	N	О.	1/0	DESCRIPTION	
NAME	TLC082-Q1	TLC084-Q1			
1IN+	3	3	I	Noninverting input, Channel 1	
1IN-	2	2	I	Inverting input, Channel 1	
1OUT	1	1	0	Output, Channel 1	
2IN+	5	5	I	Noninverting input, Channel 2	
2IN-	6	6	I	Inverting input, Channel 2	
2OUT	7	7	0	Output, Channel 2	
3IN+	_	16	I	Noninverting input, Channel 3	
3IN-	_	15	I	Inverting input, Channel 3	
3OUT	_	14	0	Output, Channel 3	
4IN+	_	18	I	Noninverting input, Channel 4	
4IN-	_	19	I	Inverting input, Channel 4	
4OUT	_	20	0	Output, Channel 4	
GND	4	17	_	Negative (lowest) power supply	
NC		8 to13		Non-connect	
VDD	8	4	I	Positive (highest) power supply	



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V_{DD}	Supply voltage ⁽²⁾	-0.3	17	V
V_{ID}	Differential input voltage		$\pm V_{DD}$	V
	Continuous total power dissipation	See Therma	I Information	
TJ	Operating junction temperature	-40	125	°C
T _A	Operating ambient temperature	-40	125	°C
$T_{J(max)}$	Maximum junction temperature		150	°C
T _{stg}	Storage temperature	-65	150	°C

⁽¹⁾ Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

				VALUE	UNIT
		Human-body model (HBM), per AEC Q100-002 ⁽¹⁾		±2000	
V _(ESD)	Electrostatic discharge		All pins	±500	V
	alsonarge	Charged-device model (CDM), per AEC Q100-011	Corner pins (1, 4, 5, and 8)	±750	

⁽¹⁾ AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

			MIN	MAX	UNIT
V _{DD} Supply voltage	Single supply	4.5	16	.,	
	Supply voltage	Split supply	±2.25	±8	V
V_{ICR}	Common-mode	input voltage	GND	V _{DD} – 2	V
TJ	Operating junction	on temperature	-40	125	°C

6.4 Thermal Information

		TLC082-Q1	TLC084-Q1	
	THERMAL METRIC ⁽¹⁾	DGN (MSOP-PowerPAD)	PWP (HTSSOP)	UNIT
		8-PIN	20-PIN	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	58.1	40	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	55.2	46.7	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	35.3	22.9	°C/W
ΨЈТ	Junction-to-top characterization parameter	2.1	1	°C/W
ΨЈВ	Junction-to-board characterization parameter	35.9	26.7	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	6.9	2.6	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

Product Folder Links: TLC082-Q1 TLC084-Q1

⁽²⁾ All voltage values, except differential voltages, are with respect to GND.



6.5 Electrical Characteristics: $V_{DD} = 5 V$

 $V_{DD} = 5 \text{ V}$ (unless otherwise noted)

	PARAMETER	TEST C	CONDITIONS	T _J ⁽¹⁾	MIN	TYP	MAX	UNIT
.,	land offertunite an	V _{DD} = 5 V. V	V _{DD} = 5 V, V _{IC} = 2.5 V,			390	1900	.,
V _{IO}	Input offset voltage	$V_0 = 2.5 \text{ V, F}$	$R_{\rm S} = 50 \Omega$	Full range			3300	μV
α_{VIO}	Temperature coefficient of input offset voltage	$V_{DD} = 5 \text{ V}, \text{ V} $ $V_{O} = 2.5 \text{ V}, \text{ F}$				1.2		μV/°C
ı	Input offeet current	V _{DD} = 5 V, V	_{IC} = 2.5 V,	25°C		1.9	50	nΛ
I _{IO}	Input offset current		$V_{O} = 2.5 \text{ V}, R_{S} = 50 \Omega$				700	pA
ı	Input bias current	V _{DD} = 5 V, V	$V_{DD} = 5 \text{ V}, V_{IC} = 2.5 \text{ V}, V_{O} = 2.5 \text{ V}, R_{S} = 50 \Omega$			3	50	pА
lВ	input bias current	$V_0 = 2.5 \text{ V}, \text{ F}$					700	PΑ
V _{ICR}	Common-mode input voltage	$R_S = 50 \Omega$		25°C	0 to 3	0 to 3.5		V
VICR	Common-mode input voltage	10 = 30 12		Full range	0 to 3	0 to 3.5		V
			$I_{OH} = -1 \text{ mA}$	25°C	4.1	4.3		
			IOH = -1 IIIA	Full range	3.9			
			I _{OH} = -20 mA	25°C	3.7	4		
VoH	High-level output voltage	V _{IC} = 2.5 V	10H - 20 IIIA	Full range	3.5			V
OH	nigh-level output voltage	VIC - 2.5 V	I _{OH} = -35 mA	25°C	3.4	3.8		V
			10H = -35 IIIA	Full range	3.2			
			I _{OH} = -50 mA	25°C	3.2	3.6		
			1 _{OH} = -30 IIIA	Full range	3			
	Low-level output voltage		I _{OL} = 1 mA	25°C		0.18	0.25	
			-	Full range			0.35	
				25°C		0.35	0.39	-
,		V 25V	$I_{OL} = 20 \text{ mA}$	Full range			0.45	
/ _{OL}		V _{IC} = 2.5 V	V _{IC} = 2.5 V	1 25 m A	25°C		0.43	0.55
					$I_{OL} = 35 \text{ mA}$	Full range		
			I _{OL} = 50 mA	25°C		0.45	0.63	
				Full range			0.7	
	Chart circuit autout aurorat	Sourcing		2500		100		Λ
os	Short-circuit output current	Sinking		25°C		100		mA
	Output source of	V _{OH} = 1.5 V f	from positive rail	0500		57		A
0	Output current	$V_{OL} = 0.5 \text{ V f}$	rom negative rail	25°C		55		mA
^	Large-signal differential voltage		D 401-0	25°C	100	120		4D
A_{VD}	amplification	$V_{O(PP)} = 3 V$	$K_L = 10 \text{ K}\Omega$	Full range	100			dB
j(d)	Differential input resistance			25°C		1000		GΩ
C _{IC}	Common-mode input capacitance	f = 10 kHz		25°C		22.9		pF
Z _O	Closed-loop output impedance	f = 10 kHz, A	u _V = 10	25°C		0.25		Ω
	Common mode rejection ratio	V = 0 to 2 V	/ B _ 50.0	25°C	70	110		40
CMRR	Common-mode rejection ratio	$V_{IC} = 0 \text{ to } 3 $	ν, κ _S = ου Ω	Full range	70			dB
	Supply voltage rejection ratio	V _{DD} = 4.5 V t	to 16 V,	25°C	80	100		-10
SVR	$(\Delta V_{DD} / \Delta V_{IO})$	$V_{IC} = V_{DD}/2$, No load		Full range	80			dB
	Complete company (respectively)	.,		25°C		1.8	2.5	
DD	Supply current (per channel)	$V_0 = 2.5 \text{ V}, \text{ N}$	NO 10aa	Full range			3.5	mA

⁽¹⁾ Full range is -40°C to 125°C.

Product Folder Links: TLC082-Q1 TLC084-Q1



6.6 Electrical Characteristics: $V_{DD} = 12 \text{ V}$

 $V_{DD} = 12 \text{ V}$ (unless otherwise noted)

	PARAMETER	TEST (CONDITIONS	T _J ⁽¹⁾	MIN	TYP	MAX	UNIT					
	least effect college	V _{DD} = 12 V,	V _{IC} = 6 V,	25°C		390	1900						
V_{IO}	Input offset voltage	$V_0 = 6 \text{ V}, R_0$		Full range			3300	μV					
ανιο	Temperature coefficient of input offset voltage		$V_{DD} = 12 \text{ V}, V_{IC} = 6 \text{ V}, V_{O} = 6 \text{ V}, R_{S} = 50 \Omega$			1.2		μV/°C					
	least effect comment	V _{DD} = 12 V,	V _{IC} = 6 V,	25°C		1.5	50	A					
I _{IO}	Input offset current		$V_{\rm O} = 6 \text{ V}, \text{ R}_{\rm S} = 50 \Omega$				700	pA					
	Innuit bing ourrent	V _{DD} = 12 V,	V _{IC} = 6 V,	25°C		3	50	~ ^					
I _{IB}	Input bias current		$V_O = 6 \text{ V}, R_S = 50 \Omega$				700	pA					
V	Common made input voltage	B 50.0		25°C	0 to 10	0 to 10.5		V					
V_{ICR}	Common-mode input voltage	$R_S = 50 \Omega$		Full range	0 to 10	0 to 10.5		V					
			l – 1 mΛ	25°C	11.1	11.2							
			$I_{OH} = -1 \text{ mA}$	Full range	11								
			l – 20 mΛ	25°C	10.8	11							
Vou	High lavel autout valtage	V 6.V	$I_{OH} = -20 \text{ mA}$	Full range	10.7								
V _{OH}	High-level output voltage	$V_{IC} = 6 V$		25°C	10.6	10.7		V					
			$I_{OH} = -35 \text{ mA}$	Full range	10.3								
				25°C	10.3	10.5							
			$I_{OH} = -50 \text{ mA}$	Full range	10.1								
	Low-level output voltage $V_{IC} = 6 \ V_{IC}$		1 4 4	25°C		0.17	0.25						
			I _{OL} = 1 mA	Full range			0.35						
			1 00 1	25°C		0.35	0.45						
			.,	.,	.,	.,	.,	.,	$I_{OL} = 20 \text{ mA}$	Full range			0.55
V_{OL}		$V_{IC} = 6 V$	I _{OL} = 35 mA	25°C		0.4	0.52	V					
				Full range			0.6						
				25°C		0.45	0.6						
			$I_{OL} = 50 \text{ mA}$	Full range			0.7						
		Sourcing				150							
los	Short-circuit output current	Sinking		25°C		150		mA					
	•		from positive rail			57							
IO	Output current	V _{OL} = 0.5 V	from negative rail	25°C		55		mA					
	Large-signal differential voltage	., .,	D /010	25°C	110	130							
A_{VD}	amplification	$V_{O(PP)} = 8 V$	$R_{L} = 10 \text{ k}\Omega$	Full range	110			dB					
r _{j(d)}	Differential input resistance			25°C		1000		GΩ					
C _{IC}	Common-mode input capacitance	f = 10 kHz		25°C		21.6		pF					
Z _O	Closed-loop output impedance	f = 10 kHz, A	A _V = 10	25°C		0.25		Ω					
	0			25°C	80	110							
CMRR	Common-mode rejection ratio	$v_{IC} = 0$ to 10	$0 \text{ V}, \text{ R}_{\text{S}} = 50 \Omega$	Full range	80			dB					
1.	Supply voltage rejection ratio	V _{DD} = 4.5 V	to 16 V, V _{IC} = V _{DD}	25°C	80	100							
k _{SVR}	$(\Delta V_{DD} / \Delta V_{IO})$	V_{DD} = 4.5 V to 16 V, V_{IC} = V_{DD} / 2, No load		Full range	80			dB					
				25°C		1.9	2.9						
I_{DD}	Supply current (per channel)	$V_0 = 7.5 \text{ V}, \text{ I}$	No load	Full range			3.5	mA					

⁽¹⁾ Full range is -40°C to 125°C.

Submit Documentation Feedback



6.7 Operating Characteristics: $V_{DD} = 5 \text{ V}$

 $V_{DD} = 5 \text{ V} \text{ (unless otherwise noted)}$

	PARAMETER	TEST CONDITIO	NS	T _J ⁽¹⁾	MIN	TYP	MAX	UNIT
SR+	Positive slew rate at unity	V 0.9.V.C 50.5F	D 1010	25°C	10	16		\//a
SK+	gain	$V_{O(PP)} = 0.8 \text{ V}, C_L = 50 \text{ pF}$	$, K_L = 10 K\Omega$	Full range	9			V/μs
SR-	Negative slew rate at unity	unity $V_{O(PP)} = 0.8 \text{ V}, C_L = 50 \text{ pF}, R_L = 10 \text{ k}\Omega$		25°C	11	19		V/μs
SK-	gain			Full range	8.5			ν/μS
V	Equivalent input noise	f = 100 Hz		25°C		12		nV/√ Hz
V _n	voltage	f = 1 kHz		25 C		8.5		HV/VHZ
In	Equivalent input noise current	f = 1 kHz		25°C		0.6		fA/√Hz
	Total harmonic distortion plus noise	V _{O(DD)} = 3 V	A _V = 1	25°C		0.002%		_
THD+N		$V_{O(PP)}$ = 3 V, R _L = 10 kΩ and 250 Ω,	A _V = 10			0.012%		
		f = 1 kHz	A _V = 100			0.085%		
	Gain-bandwidth product	$f = 10 \text{ kHz}, R_L = 10 \text{ k}\Omega$		25°C		10		MHz
		$V_{(STEP)PP} = 1 \text{ V, } A_V = -1,$	0.1%			0.18		μs
	Cattling time	$C_L = 10 \text{ pF}, R_L = 10 \text{ k}\Omega$	0.01%	0500		0.39		
t _s	Settling time	$V_{(STEP)PP} = 1 \text{ V, } A_V = -1,$	0.1%	25°C		0.18		
		$C_L = 47 \text{ pF}, R_L = 10 \text{ k}\Omega$	0.01%			0.39		
	Dhana manin	D 4010	C _L = 50 pF	0500		32		۰
φm	Phase margin	e margin $R_L = 10 \text{ k}\Omega$		25°C		40		-
	Caia mania	D 401-0	$C_L = 0 pF$ $C_L = 50 pF$	0500		2.2		4D
	Gain margin	$R_L = 10 \text{ k}\Omega$	$C_L = 0 pF$	25°C		3.3		dB

⁽¹⁾ Full range is -40° C to 125° C.

6.8 Operating Characteristics: $V_{DD} = 12 \text{ V}$

 $V_{DD} = 12 \text{ V}$ (unless otherwise noted)

	PARAMETER	TEST CONDITIO	NS	T _J ⁽¹⁾	MIN	TYP	MAX	UNIT	
SR+	Positive slew rate at unity	V 2V C 50 5 F	2 10 10	25°C	10	16		\//a	
SK+	gain	$V_{O(PP)} = 2 \text{ V}, C_L = 50 \text{ pF}, I$	$X^{\Gamma} = 10 \text{ k}$	Full range	9.5			V/μs	
SR-	Negative slew rate at unity	V - 2 V C - 50 pE	$V_{O(PP)} = 2 \text{ V, } C_L = 50 \text{ pF, } R_L = 10 \text{ k}\Omega$		12.5	19		\//a	
SK-	gain	$V_{O(PP)} = 2 V, C_L = 50 PF, V_{O(PP)}$			10			V/μs	
V	Equivalent input noise	f = 100 Hz		25°C		14		nV/√ Hz	
V _n	voltage	f = 1 kHz		25 C		8.5		IIV/ VIIZ	
In	Equivalent input noise current	f = 1 kHz		25°C		0.6		fA/√Hz	
	Total harmonic distortion plus noise	$V_{O(PP)} = 8 \text{ V},$	A _V = 1	25°C		0.002%		_	
THD+N		$R_L = 10 \text{ k}\Omega$ and 250 Ω ,	A _V = 10			0.005%			
		f = 1 kHz	A _V = 100			0.022%			
	Gain-bandwidth product	$f = 10 \text{ kHz}, R_L = 10 \text{ k}\Omega$		25°C		10		MHz	
		$V_{(STEP)PP} = 1 \text{ V}, A_V = -1,$	0.1%			0.17		μs	
	Cattling time	$C_{L} = 10 \text{ pF}, R_{L} = 10 \text{ k}\Omega$	0.01%	25°C		0.22			
t _s	Settling time	$V_{(STEP)PP} = 1 \text{ V, } A_V = -1,$	0.1%	25 C		0.17			
		$C_{L} = 47 \text{ pF}, R_{L} = 10 \text{ k}\Omega$	0.01%			0.29			
	Dhana manin	D 4010	$C_L = 50 pF$	0500		37			
φm	Phase margin	$R_L = 10 \text{ k}\Omega$	$C_L = 0 pF$	25°C		42		deg	
	O-1		$C_L = 50$	C _L = 50 pF	0500		3.1		4D
	Gain margin	$R_L = 10 \text{ k}\Omega$	$C_L = 0 pF$	25°C		4		dB	

⁽¹⁾ Full range is -40°C to 125°C.



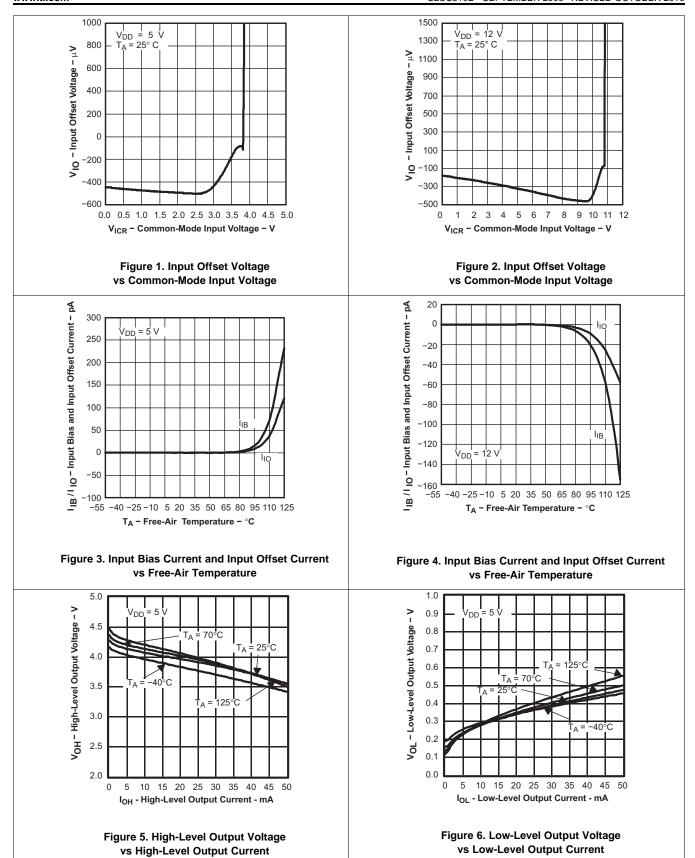
6.9 Typical Characteristics

Table 1. Table of Graphs

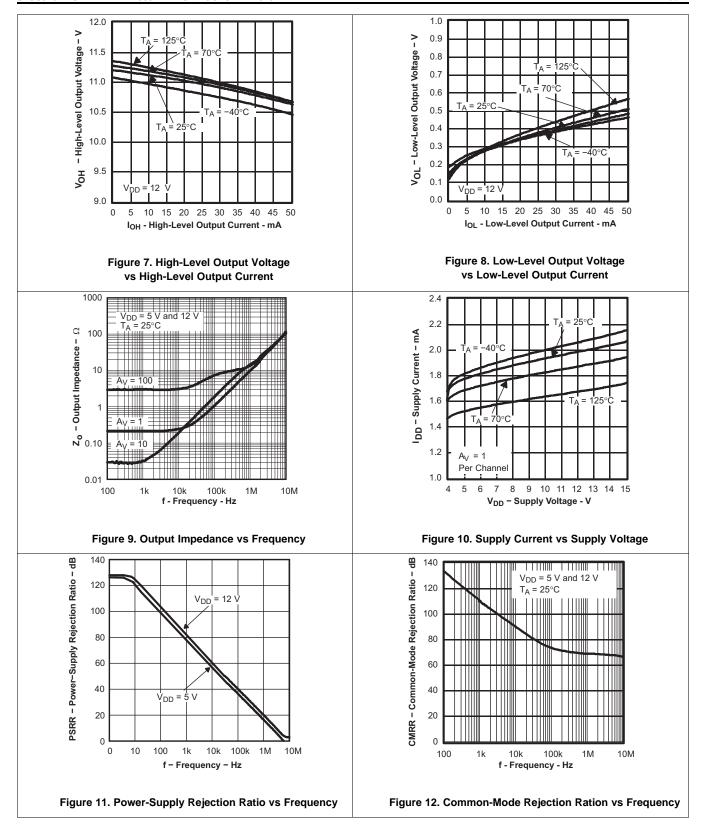
	GRAPH NAME	FIGURE NO.				
V _{IO}	Input offset voltage	vs Common-mode input voltage	Figure 1, Figure 2			
I _{IO}	Input offset current	vs Free-air temperature	Figure 3			
I _{IB}	Input bias current	vs Free-air temperature	Figure 4			
V _{OH}	High-level output voltage	vs High-level output current	Figure 5, Figure 7			
V _{OL}	Low-level output voltage	vs Low-level output current	Figure 6, Figure 8			
Z _O	Output impedance	vs Frequency	Figure 9			
I_{DD}	Supply current	vs Supply voltage	Figure 10			
PSRR	Power supply rejection ratio	vs Frequency	Figure 11			
CMRR	Common-mode rejection ratio	vs Frequency	Figure 12			
V_n	Equivalent input noise voltage	vs Frequency	Figure 13			
V _{O(PP)}	Peak-to-peak output voltage	vs Frequency	Figure 14, Figure 15			
	Crosstalk	vs Frequency	Figure 16			
	Differential voltage gain and Phase	vs Frequency	Figure 17, Figure 18			
ϕ_{m}	Phase margin	vs Load capacitance	Figure 19, Figure 20			
	Gain margin	vs Load capacitance	Figure 21, Figure 22			
	Gain-bandwidth product	vs Supply voltage	Figure 23			
SR	Slew rate	vs Supply voltage	Figure 24			
SK	Siew rate	vs Free-air temperature	Figure 25, Figure 26			
THD+N	Total harmonic distortion plus poise	vs Frequency	Figure 27, Figure 28			
I UD+N	Total harmonic distortion plus noise	vs Peak-to-peak output voltage	Figure 29, Figure 30			
	Large-signal follower pulse response		Figure 31, Figure 32			
	Small-signal follower pulse response		Figure 33			
	Large-signal inverting pulse response		Figure 34, Figure 34			
	Small-signal inverting pulse response	•	Figure 36			

Submit Documentation Feedback











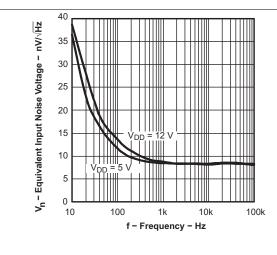


Figure 13. Equivalent Input Noise Voltage vs Frequency

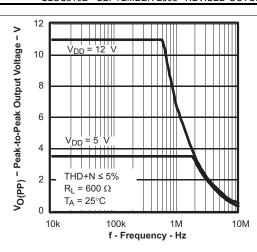


Figure 14. Peak-to-Peak Output Voltage vs Frequency

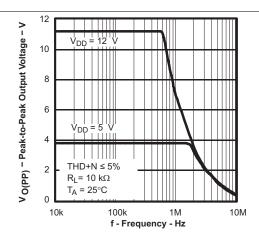


Figure 15. Peak-to-Peak Output Voltage vs Frequency

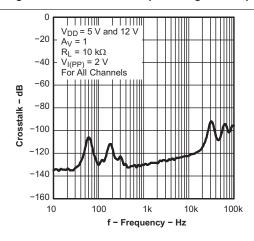


Figure 16. Crosstalk vs Frequency

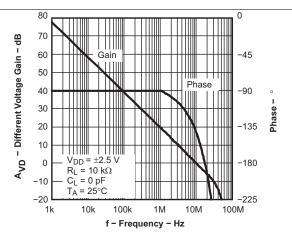


Figure 17. Differential Voltage Gain and Phase vs Frequency

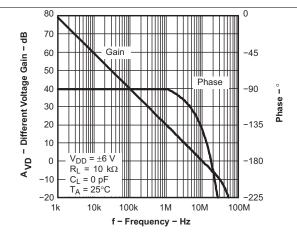
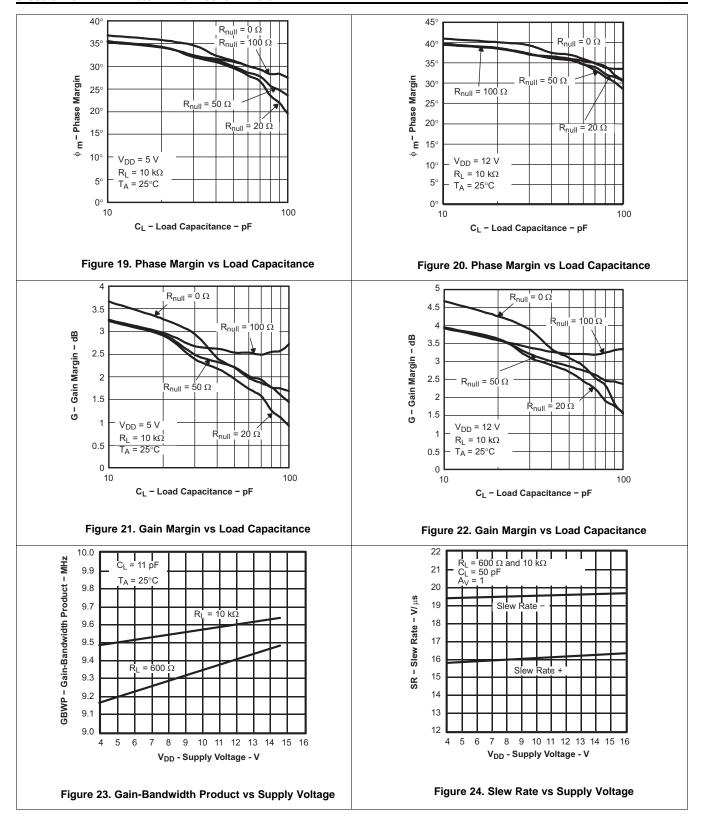


Figure 18. Differential Voltage Gain and Phase vs Frequency







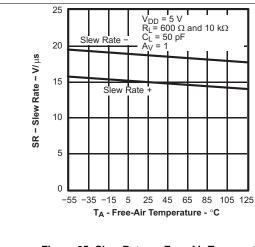


Figure 25. Slew Rate vs Free-Air Temperature

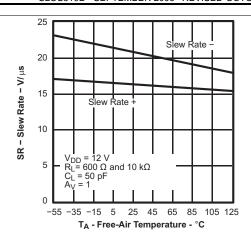


Figure 26. Slew Rate vs Free-Air Temperature

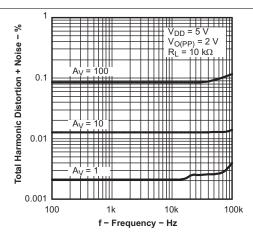


Figure 27. Total Harmonic Distortion + Noise vs Frequency

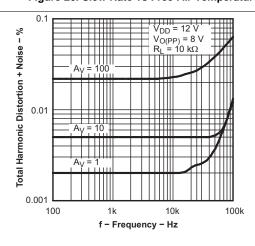


Figure 28. Total Harmonic Distortion + Noise Frequency

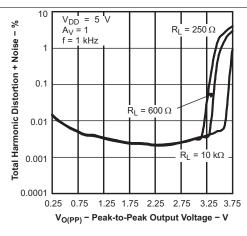


Figure 29. Total Harmonic Distortion Plus Peak-to-Peak Output Voltage

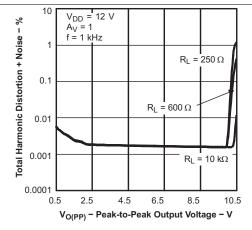
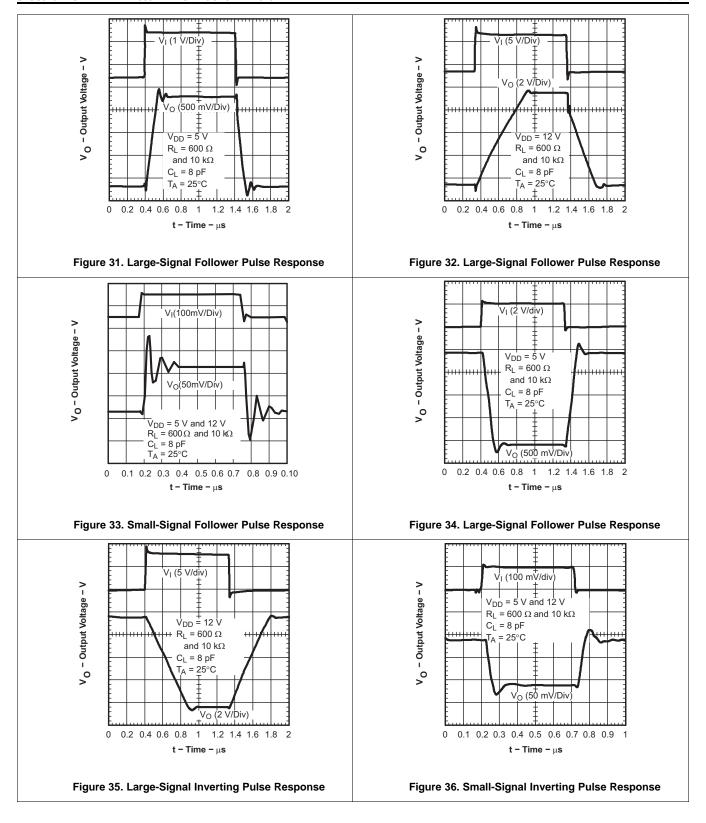


Figure 30. Total Harmonic Distortion Plus Peak-to-Peak Output Voltage







7 Parameter Measurement Information

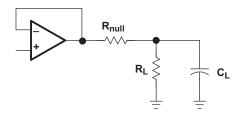


Figure 37. Voltage Follower Circuit

Submit Documentation Feedback



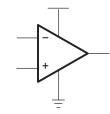
8 Detailed Description

8.1 Overview

The TLC08x-Q1 BiCMOS amplifiers provide an upgrade path for BiFET users who are moving away from dual-supply to single-supply systems and demand higher AC and DC performance. With performance rated from 4.5 V to 16 V across an automotive temperature range (–40°C to 125°C), BiMOS suits a wide range of audio, automotive, industrial, and instrumentation applications. BiCMOS amplifiers combine a very high input low-noise CMOS front end drive bipolar output stage, thus providing the optimum performance features of both. AC performance include a bandwidth of 10 MHz and voltage noise of 8.5 nV/ $\sqrt{\text{Hz}}$.

8.2 Functional Block Diagram





8.3 Feature Description

The TLC08x-Q1 family features 10-MHz bandwidth and voltage noise of 8.5 nV/ $\sqrt{\text{Hz}}$ with performance rated from 4.5 V to 16 V across an automotive temperature range (-40°C to 125°C). BiMOS suits a wide range of audio, automotive, industrial, and instrumentation applications.

8.4 Device Functional Modes

The TLC08x-Q1 family of devices is powered on when the supply is connected. The device can operate with single or dual supply, depending on the application. The device is in its full performance once the supply is above the recommended value.

8.5 Programming

8.5.1 Macromodel Information

Derivation of the provided macromodel information was by use of Microsim PartsTM, the model generation software used with Microsim PSpiceTM. The Boyle macromodel ⁽¹⁾ and subcircuit in Figure 38 are generated using the TLC08x-Q1 typical electrical and operating characteristics at $T_A = 25$ °C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- · Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification
- Unity-gain frequency
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

(1) G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, *Macromodeling of Integrated Circuit Operational Amplifiers*, IEEE Journal of Solid-State Circuits, SC-9, 353 (1974).

Submit Documentation Feedback



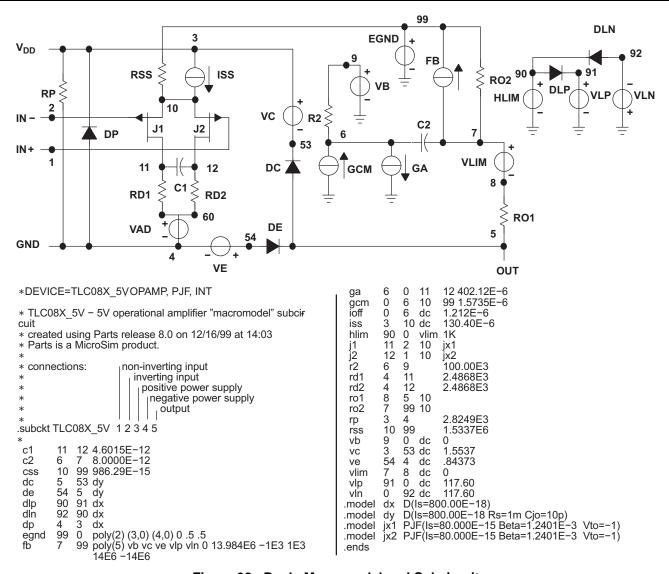


Figure 38. Boyle Macromodel and Subcircuit



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TLC08x-Q1 devices features wide supply voltage range, high-output current drive in the order of 60 mA, low input offset voltage, a high unity gain bandwidth 10 MHz and high slew of 16 V/µS. These features make the device suitable in amplifying high-frequency and slew rate signals.

9.2 Typical Applications

9.2.1 TLC08x-Q1 Single-Supply Typical Application

Some applications require amplification of low amplitude and relatively high-frequency input signal. The sine wave maximum slew rate is at zero crossing. The amplified signal distorts if the minimum slew rate is not met. Operational amplifier slew rate must be higher than $2 \times \pi \times F \times V$, where F is the input signal frequency and V is the output signal amplitude. TLC08x-Q1 Slew rate of 16 V/ μ S is capable of delivering an output signal of 2-V peak and 1-MHz frequency with no distortion. See Figure 45 for an application curve that shows the results of Figure 39.

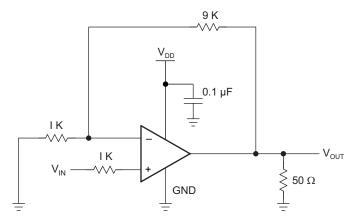


Figure 39. TLC08x-Q1 Typical Application

9.2.1.1 Design Requirements

Use the following parameters for this design example:

- · Noninverting configuration with gain of 10 or 20 dB
- Single supply minimum: 4.5 V
- Single supply maximum: 16 V
- Output common mode minimum should be higher than output level V_{OI}
- Output common mode maximum should be lower than output level V_{OH}
- Unity gain bandwidth: 10 MHz
- · Output load current lower than 60 mA
- Maximum input signal frequency below 1 MHz for less than –3-dB attenuation at 1 MHz

Submit Documentation Feedback



9.2.1.2 Detailed Design Procedure

9.2.1.2.1 Driving a Capacitive Load

When the amplifier is configured in this manner, capacitive loading directly on the output decreases the device phase margin, leading to high-frequency ringing or oscillations. Therefore, for capacitive loads of greater than 10 pF, TI recommends placing a resistor in series (R_{NULL}) with the output of the amplifier, as shown in Figure 40. A minimum value of 20 Ω should work well for most applications.

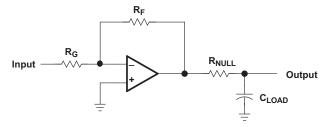


Figure 40. Driving a Capacitive Load

9.2.1.2.2 Offset Voltage

The output offset voltage, (V_{OO}) is the sum of the input offset voltage (V_{IO}) and both input bias currents (I_{IB}) times the corresponding gains. The schematic and formula in Figure 41 can be used to calculate the output offset voltage.

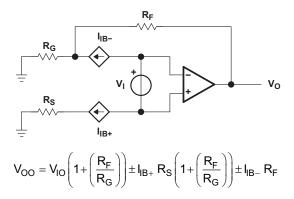


Figure 41. Output Offset Voltage Model

9.2.1.2.3 High-Speed CMOS Input Amplifiers

The TLC08x-Q1 is a family of high-speed low-noise CMOS input operational amplifiers that has an input capacitance on the order of 20 pF. Any resistor used in the feedback path adds a pole in the transfer function equivalent to the input capacitance multiplied by the combination of source resistance and feedback resistance. For example, a gain of -10, a source resistance of 1 k Ω , and a feedback resistance of 10 k Ω add an additional pole at approximately 8 MHz. This is more apparent with CMOS amplifiers than bipolar amplifiers due to their greater input capacitance.

This is of little consequence on slower CMOS amplifiers, as this pole normally occurs at frequencies above their unity-gain bandwidth. However, the TLC08x-Q1 with its 10-MHz bandwidth means that this pole normally occurs at frequencies where there is on the order of 5-dB gain left and the phase shift adds considerably.

The effect of this pole is the strongest with large feedback resistances at small closed-loop gains. As the feedback resistance is increased, the gain peaking increases at a lower frequency and the 180° phase-shift crossover point also moves down in frequency, decreasing the phase margin.

For the TLC08x-Q1, the maximum feedback resistor recommended is 5 kΩ; larger resistances can be used but a capacitor in parallel with the feedback resistor is recommended to counter the effects of the input capacitance pole.

Submit Documentation Feedback



The TLC08x-Q1 with a 1-V step response has an 80% overshoot with a natural frequency of 3.5 MHz when configured as a unity gain buffer and with a $10-k\Omega$ feedback resistor. By adding a 10-pF capacitor in parallel with the feedback resistor, the overshoot is reduced to 40% and eliminates the natural frequency, resulting in a much faster settling time (see Figure 42). The 10-pF capacitor was chosen for convenience only.

Load capacitance had little effect on these measurements due to the excellent output drive capability of the TLC08x-Q1.

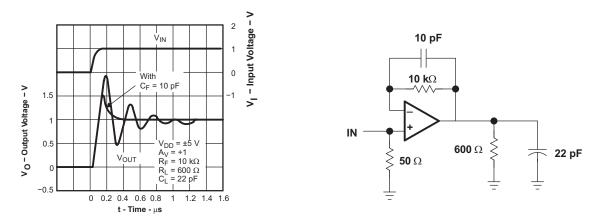


Figure 42. 1-V Step Response

9.2.1.2.4 General Configurations

When receiving low-level signals, limiting the bandwidth of the incoming signals into the system is often required. The simplest way to accomplish this is to place an RC filter at the noninverting terminal of the amplifier (see Figure 43).

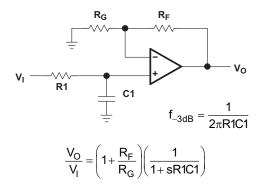


Figure 43. Single-Pole Low-Pass Filter

If even more attenuation is needed, a multiple-pole filter is required. The Sallen-Key filter can be used for this task. For best results, the amplifier should have a bandwidth that is eight to ten times the filter frequency bandwidth. Failure to do this can result in phase shift of the amplifier.

Submit Documentation Feedback



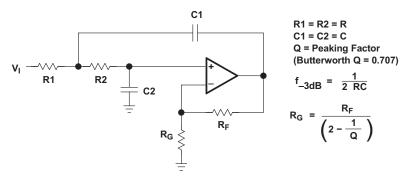
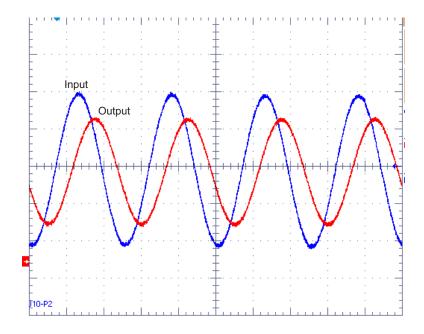


Figure 44. 2-Pole Low-Pass Sallen-Key Filter

9.2.1.3 Application Curve



Gain Vout / Vin = 1.471 V / 0.2 V = 7.335 Gain(db) = 20 Log (7.335) = 17.33 dB and is 2.7 dB below 10 dB

Figure 45. Single Supply Application at 1-MHz Input Signal



9.2.2 Dual-Supply Typical Application

The dual-supply application has a gain of 10 and a bandwidth of 1 MHz.

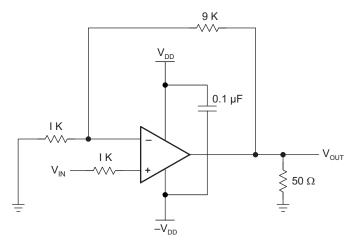


Figure 46. Dual Supply Typical Application Schematic

9.2.2.1 Design Requirements

Use the following parameters for this design example:

- Noninverting configuration with gain of 10 or 20 dB
- Dual supply minimum: ±2.25 V
- Dual supply maximum: ±8 V
- Output common mode minimum should be higher than output level V_{OL}
- Output common mode maximum should be lower than output level V_{OH}
- Unity gain bandwidth: 10 MHz
- Maximum input signal frequency is 1 MHz for less than 3-dB attenuation at 1 MHz
- Output load current lower than 60 mA

9.2.2.2 Detailed Design Procedure

For this example, see Detailed Design Procedure in TLC08x-Q1 Single-Supply Typical Application.

Submit Documentation Feedback



9.2.2.3 Application Curve

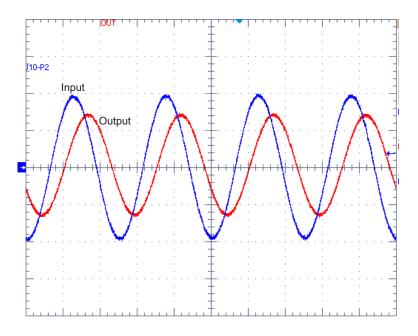


Figure 47. Dual Supply Application at 1-MHz Input Signal

10 Power Supply Recommendations

The TLC08x-Q1 operational amplifier is specified for use on a single supply from 4.5 V to 16 V (or a dual supply from over a temperature range of -40°C to 125°C. The device continues to function below this range, but performance is not specified. Place bypass capacitors close to the power supply pins to reduce noise coupling in from noisy or high-impedance power supplies. For more detailed information on bypass capacitor placement, see *Layout Guidelines*.

11 Layout

11.1 Layout Guidelines

To achieve the levels of high performance of the TLC08x-Q1, follow proper printed-circuit board (PCB) design techniques. A general set of guidelines is given in the following.

Ground planes TI highly recommends using a ground plane on the board to provide all components with a low-inductive ground connection. However, in the areas of the amplifier inputs and output, the ground plane can be removed to minimize the stray capacitance.

Proper power-supply decoupling Use a 6.8- μ F tantalum capacitor in parallel with a 0.1- μ F ceramic capacitor on each supply terminal. It may be possible to share the tantalum among several amplifiers depending on the application, but a 0.1- μ F ceramic capacitor should always be used on the supply terminal of every amplifier. In addition, the 0.1- μ F capacitor should be placed as close as possible to the supply terminal. As this distance increases, the inductance in the connecting trace makes the capacitor less effective. The designer should strive for distances of less than 0.1 inches between the device power terminals and the ceramic capacitors.

Sockets

Sockets can be used but are not recommended. The additional lead inductance in the socket pins will often lead to stability problems. Surface-mount packages soldered directly to the PCB is the best implementation.



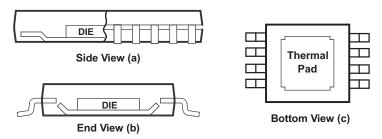
Layout Guidelines (continued)

Short trace runs and compact part placements Optimum high performance is achieved when stray series inductance has been minimized. To realize this, the circuit layout should be made as compact as possible, thereby minimizing the length of all trace runs. Particular attention should be paid to the inverting input of the amplifier. Its length should be kept as short as possible. This helps minimize stray capacitance at the input of the amplifier.

Surface-mount passive components TI recommends using surface-mount passive components for highperformance amplifier circuits for several reasons. First, because of the extremely low lead inductance of surface-mount components, the problem with stray series inductance is greatly reduced. Second, the small size of surface-mount components naturally leads to a more-compact layout, thereby minimizing both stray inductance and capacitance. If leaded components are used, TI recommends keeping the lead lengths as short as possible.

11.1.1 General PowerPAD™ Design Considerations

The TLC08x-Q1 is available in a thermally-enhanced PowerPAD family of packages. These packages are constructed using a downset leadframe upon which the die is mounted [see Figure 48(a) and Figure 48(b)]. This arrangement results in the lead frame being exposed as a thermal pad on the underside of the package [see Figure 48(c)]. Because this thermal pad has direct thermal contact with the die, excellent thermal performance can be achieved by providing a good thermal path away from the thermal pad.



NOTE A: The thermal pad is electrically isolated from all terminals in the package.

Figure 48. Views of Thermally-Enhanced DGN Package

The PowerPAD package allows for both assembly and thermal management in one manufacturing operation. During the surface-mount solder operation (when the leads are being soldered), the thermal pad must be soldered to a copper area underneath the package. Through the use of thermal paths within this copper area, heat can be conducted away from the package into either a ground plane or other heat dissipating device.

Soldering the thermal pad to the PCB is always required, even with applications that have low power dissipation.

This soldering provides the necessary thermal and mechanical connection between the lead frame die pad and the PCB. Although there are many ways to properly heatsink the PowerPAD package, the following steps list the recommended approach.

The thermal pad must be connected to the most-negative supply voltage (GND pin potential) of the device.

- 1. Prepare the PCB with a top-side etch pattern (see the landing patterns at the end of this data sheet). There should be etch for the leads, as well as etch for the thermal pad.
- 2. Place five holes (dual) or nine holes (quad) in the area of the thermal pad. These holes should be 13 mils in diameter. Keep them small so that solder wicking through the holes is not a problem during reflow.
- 3. Additional vias may be placed anywhere along the thermal plane outside of the thermal pad area. This helps dissipate the heat generated by the TLC08x-Q1 device. These additional vias may be larger than the 13-mil diameter vias directly under the thermal pad. They can be larger because they are not in the thermal-pad area to be soldered, so that wicking is not a problem.

Product Folder Links: TLC082-Q1 TLC084-Q1

4. Connect all holes to the internal plane that is at the same potential as the ground pin of the device.

Submit Documentation Feedback



Layout Guidelines (continued)

- 5. When connecting these holes to this internal plane, do not use the typical web or spoke via connection methodology. Web connections have a high-thermal-resistance connection that is useful for slowing the heat transfer during soldering operations. This makes the soldering of vias that have plane connections easier. In this application, however, low thermal resistance is desired for the most efficient heat transfer. Therefore, the holes under the TLC08x-Q1 PowerPAD package should make their connection to the internal ground plane with a complete connection around the entire circumference of the plated-through hole.
- 6. The top-side solder mask should leave the terminals of the package and the thermal-pad area with its five holes (dual) or nine holes (quad) exposed. The bottom-side solder mask should cover the five or nine holes of the thermal-pad area. This prevents solder from being pulled away from the thermal-pad area during the reflow process.
- 7. Apply solder paste to the exposed thermal-pad area and all of the IC terminals.
- 8. With these preparatory steps in place, the TLC08x-Q1 IC is simply placed in position and run through the solder reflow operation as any standard surface-mount component. This results in a part that is properly installed.

For a given $R_{\theta,JA}$, use Equation 1 to calculate the maximum power dissipation.

$$P_{D} = \left(\frac{T_{MAX} - T_{A}}{R_{\theta JA}}\right)$$

Where:

P_D = Maximum power dissipation of TLC08x IC (watts)

 T_{MAX} = Absolute maximum junction temperature (150°C)

T_A = Free-ambient air temperature (°C)

 $R_{\theta JA} = R_{\theta JC} + R_{\theta CA}$

 $R_{\theta JC}$ = Thermal coefficient from junction to case

 $R_{\theta CA}$ = Thermal coefficient from case to ambient air (°C/W)

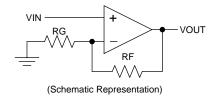
The next consideration is the package constraints. The two sources of heat within an amplifier are quiescent power and output power. The designer should never forget about the quiescent heat generated within the device, especially multi-amplifier devices. Because these devices have linear output stages (class A-B), most of the heat dissipation is at low-output voltages with high-output currents.

The other key factor when dealing with power dissipation is how the devices are mounted on the PCB. The PowerPAD devices are extremely useful for heat dissipation. But, the device should always be soldered to a copper plane to fully use the heat dissipation properties of the thermal pad. The SOIC package, on the other hand, is highly dependent on how it is mounted on the PCB. As more trace and copper area is placed around the device, $R_{\theta JA}$ decreases and the heat dissipation capability increases. The currents and voltages shown in *Typical Characteristics* are for the total package. For the dual or quad amplifier packages, the sum of the RMS output currents and voltages should be used to choose the proper package.

(1)



11.2 Layout Example



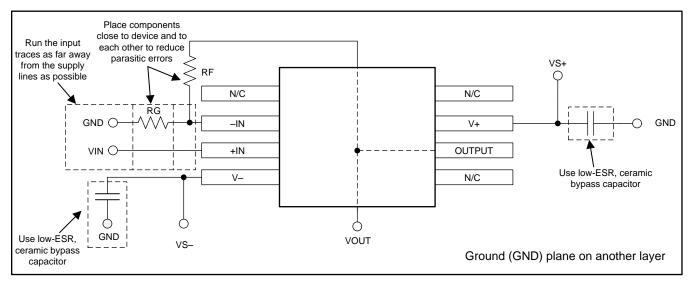


Figure 49. Operational Amplifier Board Layout for Noninverting Configuration

Submit Documentation Feedback



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

TLC081 EMI Immunity Performance (SBOT011)

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 2. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY		
TLC082-Q1	Click here	Click here	Click here	Click here	Click here		
TLC084-Q1	Click here	Click here	Click here	Click here	Click here		

12.3 Receiving Notification of Documentsation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.5 Trademarks

PowerPAD, E2E are trademarks of Texas Instruments. Parts, PSpice are trademarks of MicroSim Corporation.

All other trademarks are the property of their respective owners.

12.6 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most-current data available for the designated devices. This data is subject to change without notice and without revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation pane.

www.ti.com 10-Nov-2025

PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
TLC082QDGNRQ1	Active	Production	HVSSOP (DGN) 8	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	QXO
TLC082QDGNRQ1.A	Active	Production	HVSSOP (DGN) 8	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	QXO
TLC082QDGNRQ1.B	Active	Production	HVSSOP (DGN) 8	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	QXO
TLC084QPWPRQ1	Active	Production	HTSSOP (PWP) 20	2000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLC084Q
TLC084QPWPRQ1.A	Active	Production	HTSSOP (PWP) 20	2000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLC084Q
TLC084QPWPRQ1.B	Active	Production	HTSSOP (PWP) 20	2000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLC084Q

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

www.ti.com 10-Nov-2025

OTHER QUALIFIED VERSIONS OF TLC082-Q1, TLC084-Q1:

● Catalog : TLC082, TLC084

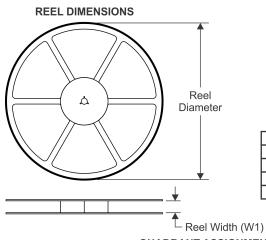
NOTE: Qualified Version Definitions:

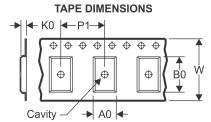
Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

www.ti.com 6-Sep-2019

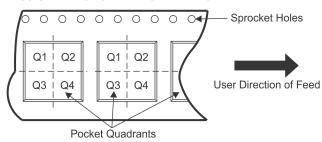
TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

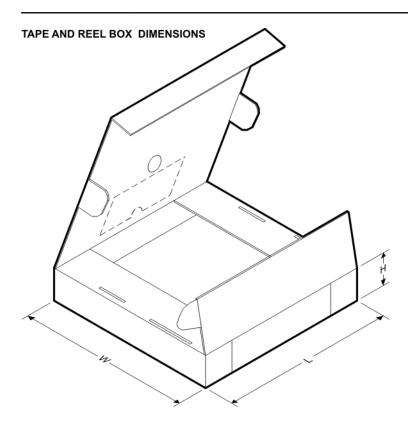


*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC082QDGNRQ1	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 6-Sep-2019



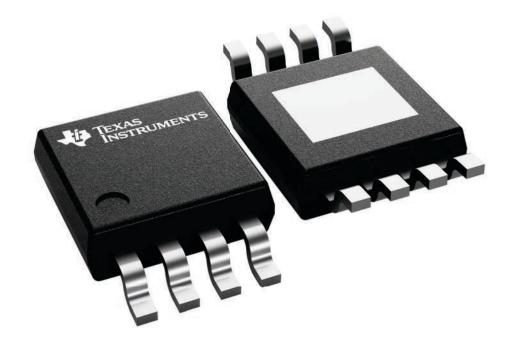
*All dimensions are nominal

Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TLC082QDGNRQ1	HVSSOP	DGN	8	2500	346.0	346.0	29.0	

3 x 3, 0.65 mm pitch

SMALL OUTLINE PACKAGE

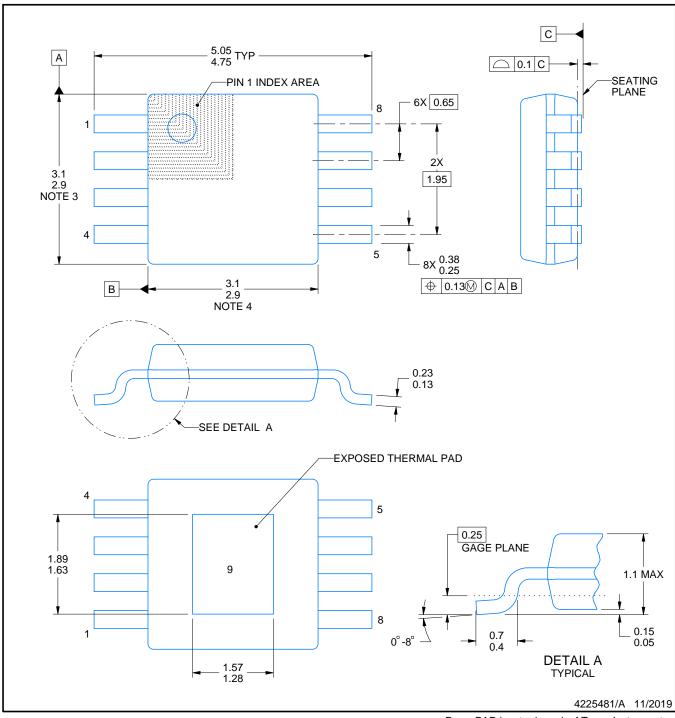
This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



INSTRUMENTS www.ti.com

$\textbf{PowerPAD}^{^{\text{\tiny{TM}}}}\,\textbf{VSSOP - 1.1 mm max height}$

SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

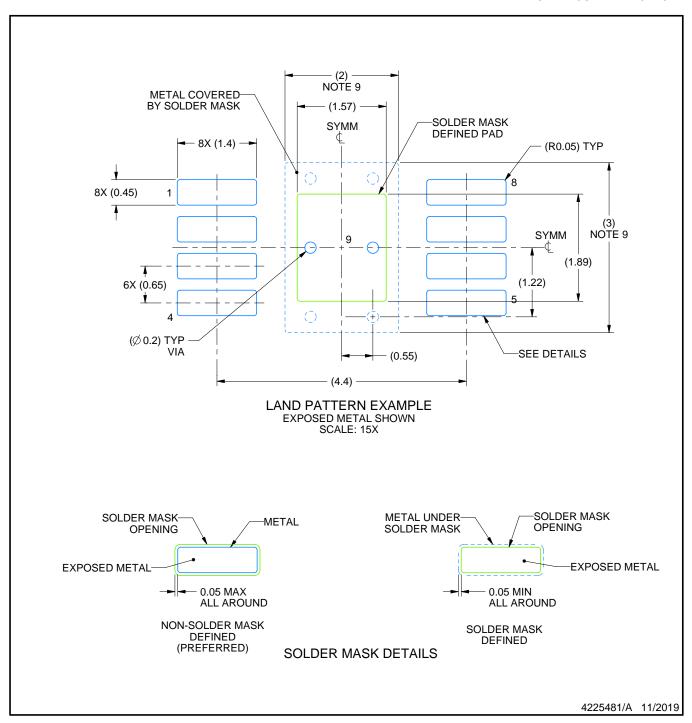
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE

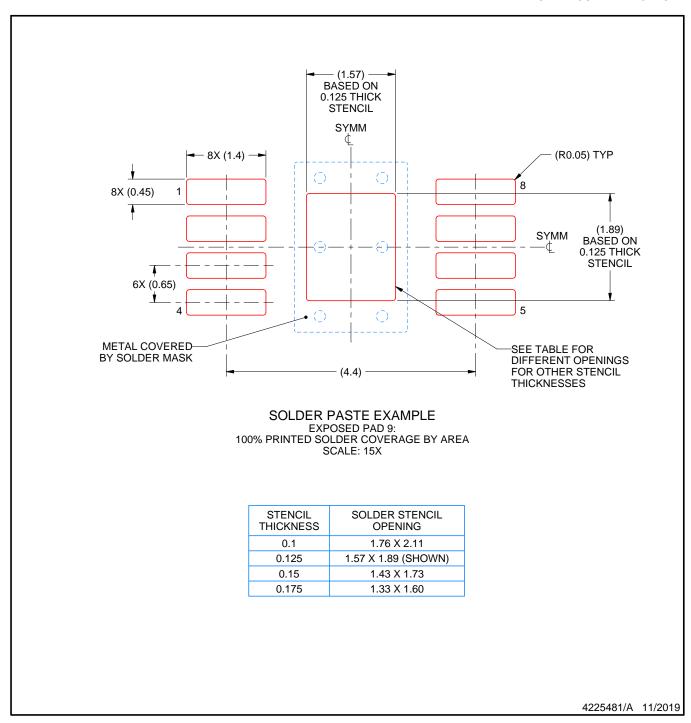


NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



SMALL OUTLINE PACKAGE



NOTES: (continued)

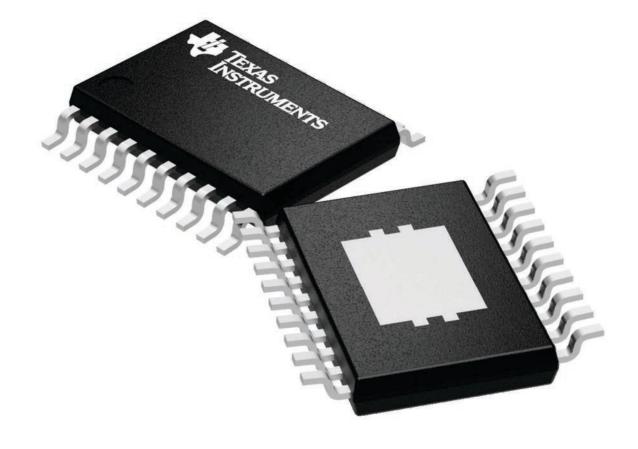
- 10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 11. Board assembly site may have different recommendations for stencil design.



6.5 x 4.4, 0.65 mm pitch

SMALL OUTLINE PACKAGE

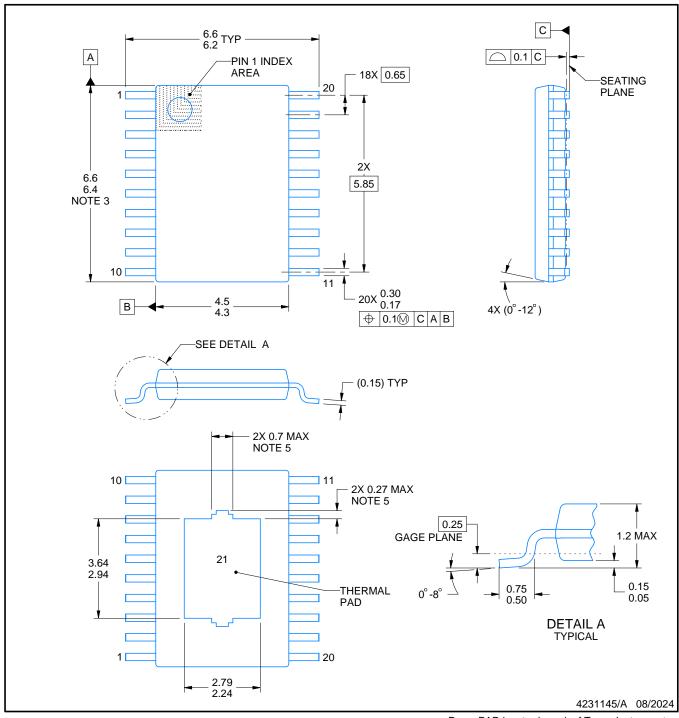
This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





PowerPAD[™] TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



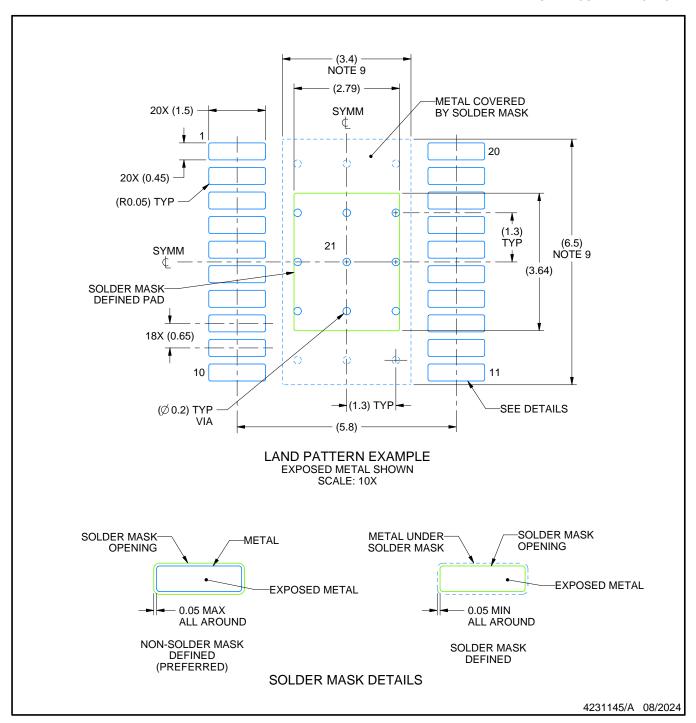
PowerPAD is a trademark of Texas Instruments.

NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
- 4. Reference JEDEC registration MO-153.
- 5. Features may differ or may not be present.



SMALL OUTLINE PACKAGE

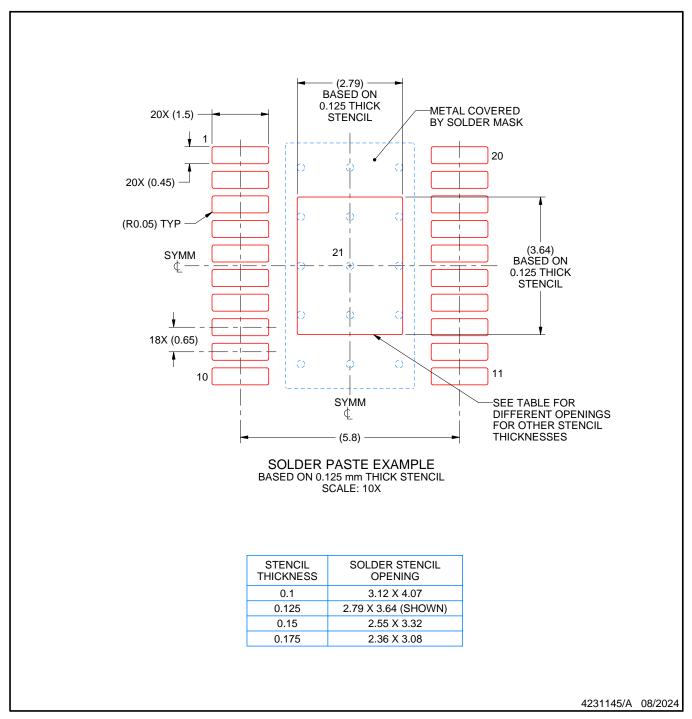


NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 (www.ti.com/lit/slma002) and SLMA004 (www.ti.com/lit/slma004).
- 9. Size of metal pad may vary due to creepage requirement.
- 10. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025